

**Search Notes**

Application/Control No.

10/747,599

Examiner

George A. Goudreau

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

1763

**SEARCHED**

Class	Subclass	Date	Examiner
438	257	4-07	GAG
438	266		GAG
438	289		GAG
438	296		GAG
438	593		GAG
438	595		GAG
438	596		GAG
438	696		GAG

**INTERFERENCE SEARCHED**

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438	257	4-07	GAG
438	266		GAG
438	289		GAG
438	296		GAG

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN: CAPLUS, JAPIO, INSPEC, USPATFULL	4-07	GAG
EAST: USPB, USPT, WPID, JPO		GAG

**Search Notes (continued)**

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438	593	4-07-1	GAG
438	595		GAG
438	596		GAG
438	696	▽	GAG

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